


<b>Search Notes</b>  	<b>Application/Control No.</b>  10762551	<b>Applicant(s)/Patent Under Reexamination</b>  FUTAMI ET AL.
	<b>Examiner</b>  Kim, David S	<b>Art Unit</b>  2613

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST search - see search history printout	1/6/2007	DSK
scholar.google.com - various combinations of the following terms: supercontinuum morioka 1995 kawanishi optical tdm wdm liou system performance 200 nm penalty-free prescaled pll lightwave 50km multiwavelength picosecond otd/wdm	1/6/2007	DSK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner